



LoRa accredited Test Lab



Test report No:

NIE: 73825RLR.002A1

Test report

LoRa Alliance End Device Certification Requirements

(*) Identification of item tested	LSM100A
(*) Trademark	SJIT Co.,Ltd
(*) Model and /or type reference tested	Module
(*) Other identification of the product	Final HW version: V0.3 Final FW Version: V1.0.3
(*) Features	EU863-870 Band, Class A, Class C (Temporary) DUT supports both activation modes (ABP & OTAA). Test sample description.
Manufacturer	SJIT Co.,Ltd Address: 54-11, Dongtanhana 1-gil, Hwaseong-si Postal code/City: 18423, Gyeonggi-do Republic of Korea
Test method requested, standard	Lora Alliance Certification Program
Standard:	LoRaWAN v1.0.4
Test Specification:	LoRa Alliance End-Device Certification Requirements for All Regions
LoRa_Certification_Questionnaire:	LoRaWAN_Certification_Questionnaire_V2.2
Test procedure(s)	PELR000_00 LoRa Alliance Testing Procedure
Supported Optional Features Adaptive Data Rate (ADR): SF7BW250: FSK50:	Yes Yes Yes
Summary	IN COMPLIANCE
Approved by (name / position & signature)	Noemí Pérez Dans
	IoT Lab. Manager
Date of issue	2024-01-30
Report template No	FLR001_05 (*) "Data provided by the client"



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Competences and guarantees

DEKRA Testing and Certification S.A.U is a LoRa Alliance accredited Test Lab competent to carry out the tests described in this report.

In order to assure the traceability to other national and international laboratories, DEKRA Testing and Certification S.A.U. has a calibration and maintenance program for its measurement equipment.

DEKRA Testing and Certification S.A.U. guarantees the reliability of the data presented in this report, which is the result of the measurements and the tests performed to the item under test on the date and under the conditions stated on the report and, it is based on the knowledge and technical facilities available at DEKRA Testing and Certification at the time of performance of the test.

DEKRA Testing and Certification S.A.U. is liable to the client for the maintenance of the confidentiality of all information related to the item under test and the results of the test.

The results presented in this Test Report apply only to the particular item under test established in this document.

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General conditions

- 1. This report is only referred to the item that has undergone the test.
- 2. This report does not constitute or imply on its own an approval of the product by the Certification Bodies or competent Authorities.
- 3. This document is only valid if complete; no partial reproduction can be made without previous written permission of DEKRA Testing and Certification S.A.U.
- 4. This test report cannot be used partially or in full for publicity and/or promotional purposes without previous written permission of DEKRA Testing and Certification S.A.U. and the Accreditation Bodies.



Uncertainty

N/A

Data provided by the client

The following data has been provided by the client:

- 1. Information relating to the description of the sample ("Identification of item tested ", "Trademark", "Model and /or type reference tested", "Derived model not tested", "Other identification of the product", "Features" and "Test Sample Description").
- 3. The ICS provided by the customer via the LoRa_Certification_Questionnaire_V2.2 and used for testing are indicated in Annex B.

DEKRA Testing and Certification S.A.U. declines any responsibility with respect to the information provided by the client and that may affect the validity of results.

Usage of samples

Samples undergoing test have been selected by: SJIT Co.,Ltd

Sample M/01 is composed of the following elements:

Control Nº	Description	Model	Serial Nº	Date of reception
73825B/001	Module	LSM100A	-	2023-02-21
	FW v1.0.3			

^{1.} Sample M/01 has undergone the test(s) specified in subclause "Test method requested".

(*)Test sample description

LSM100A is the smarter combination module that is adopted 2 leading LPWA technology, LoRa and Sigfox together. It helps customer cost-down because it supports dual technologies with one module.

Identification of the client

SJIT Co.,Ltd

Address: 54-11, Dongtanhana 1-gil, Hwaseong-si

Postal code/City: 18423, Gyeonggi-do

Republic of Korea

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Testing period and place

Test Location	DEKRA Testing and Certification S.A.U.
Date (start)	2023-02-21
Date (finish)	2023-05-04

Document history

Report number	Date	Description
73825BRLR.002	2023-06-12	First release (test report without logs to be uploaded to the public area of LoRa Alliance website)
73825RLR.002A1	2024-01-30	Company name update. This document supersedes 73825BRLR.002

Remarks and comments

Testing was performed by: Martín Sánchez Revuelta and Pablo Ferrín Lorenzo

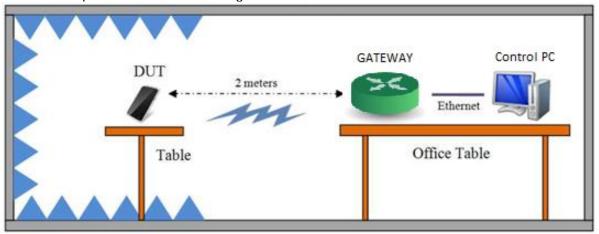
Means of testing identification

DEKRA Authorized Test Lab used the approved test environment recipe for their certification test results as follows:

LCTT GUI version	LCTT Test Cases Package Version	DUT inside RF Chamber	Gateways model
V2.5.0	V3.9.0_R1	Yes	2 x Corecell SX1302C868GW1

Test setup

This Test Setup has been used for testing:



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Testing verdicts

Not applicable :	N/A
Pass :	Р
Fail :	F
Not measured :	N/M



Appendix A: Test results

Test campaign report

The abbreviations used in the header row of the test campaign report tables are:

Test Case ID: As it can be found on the standard

Verdict: Records the verdict assigned to each Test Case run to completion (Testing

verdicts)

Date: Date of the beginning of the execution.

Observations: Provides a reference to additional information relevant to the test presented

in "Test Setup" section.

Logs: Shared via FTP

ition Pre-test	04/05/2023	Р	
tion Pre-test	04/05/2022		
	04/05/2023	Р	
The Air Activation	04/05/2023	Р	
tion by Personalization	04/05/2023	Р	
ography	04/05/2023	Р	
link Sequence Number	04/05/2023	Р	
med Frames	04/05/2023	Р	
atusReq MAC command	04/05/2023	Р	
•	04/05/2023	Р	
• •	04/05/2023	Р	
	04/05/2023	Р	
ningSetupReq MAC command	04/05/2023	P	
amSetupReq MAC command	04/05/2023	Р	
neckReq MAC command	04/05/2023	Р	
DDReq MAC command (Part 1)	04/05/2023	Р	
DDReq MAC command (Part 2)	04/05/2023	Р	
cycleReq MAC Command	04/05/2023	Р	
eTimeReq MAC Command	04/05/2023	Р	
/indow Test (Part 1)	04/05/2023	Р	
	The Air Activation Intion by Personalization	The Air Activation 04/05/2023 Intion by Personalization 04/05/2023 Degraphy 04/05/2023 Dink Sequence Number 04/05/2023 Dink Se	The Air Activation 04/05/2023 P pation by Personalization 04/05/2023 P pagraphy 04/05/2023 P pagraphy 04/05/2023 P patink Sequence Number

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TP_A_EU868_ED_MAC_104_BV_015_B	RX1 Window Test (Part 2)	04/05/2023	Р
TP_A_EU868_ED_MAC_104_BV_016	RX2 Receive Window Test	04/05/2023	Р
TP_A_EU868_ED_MAC_104_BV_017	RX1 and RX2 simultaneous frames	04/05/2023	Р
TP_A_EU868_ED_MAC_104_BV_018	RX Oversized Payload	04/05/2023	Р
TP_A_EU868_ED_MAC_104_BV_019_A	Maximum Allowed Payload (Part 1)	04/05/2023	Р
TP_A_EU868_ED_MAC_104_BV_019_B	Maximum Allowed Payload (Part 2)	04/05/2023	Р
TP_A_EU868_ED_MAC_104_BV_020	MAC Command(s) in App-Payload and/or Frame Options	04/05/2023	Р
TP_A_EU868_ED_MAC_104_BV_021	Multiple MAC commands prioritation	04/05/2023	Р
TP_A_EU868_ED_MAC_104_BV_022	FPort 224 Deactivation	04/05/2023	Р
TP_C_EU868_ED_MAC_104_BV_000	Activation and Usage	19/05/2023	Р



Appendix B: ICS

Implementation Conformance Statement (ICS)

Name	Title	Groupname	Mandatory	Value
C_ISM_AS923	DUT works in Asia 923MHz ISM Band	BAND		FALSE
C_ISM_AU915	DUT works in Australia 915MHz ISM Band	BAND	=	FALSE
C_ISM_EU868	DUT works in EU 868MHz ISM Band	BAND	-	TRUE
C_ISM_IN865	DUT works in India 865-867 MHz ISM Band	BAND	-	FALSE
C_ISM_KR920	DUT works in South Korea 920MHz ISM Band	BAND	-	FALSE
C_ISM_RU864	DUT works in Rusia 864MHz ISM Band	BAND	-	FALSE
C_ISM_US915	DUT works in USA 915MHz ISM Band	BAND	-	FALSE
C_CERT_102rB	DUT implements LoRaWAN v1.0.2rB certification requirements	CERT	-	FALSE
C_CERT_104	DUT implements LoRaWAN v1.0.4 certification requirements	CERT	-	TRUE
C_CLASS_A	DUT is a Class A Device (All End Devices)	CLASS	-	TRUE
C_CLASS_B	DUT is a Class B Device (Beacon Mode)	CLASS	-	FALSE
C_CLASS_C	DUT is a Class C Device (Continuously Listening)	CLASS	-	TRUE
C_ED_ADR	DUT supports Adaptive Data Rate (ADR) feature	ED	=	TRUE
C_ED_ADR_BLOCK	DUT supports LinkADRReq block	ED	-	FALSE
C_ED_AS923_GROUP1	DUT works in Asia 923MHz ISM Band Group 1	ED	-	FALSE
C_ED_AS923_GROUP2	DUT works in Asia 923MHz ISM Band Group 2	ED	-	FALSE
C_ED_AS923_GROUP3	DUT works in Asia 923MHz ISM Band Group 3	ED	-	FALSE
C_ED_AS923_GROUP4	DUT works in Asia 923MHz ISM Band Group 4	ED	-	FALSE
C_ED_DL_CHAN	DUT supports DIChannelReq MAC command	ED	-	FALSE
C_ED_OTAA	DUT supports Over-The-Air Activation (OTAA) mechanism	ED	-	TRUE
C_ED_PERMANENT_CLASS_C	DUT permanently enabled Class C	ED	-	FALSE
C_ED_RESET	DUT needs a reset after deactivating Test Mode	ED	-	FALSE
C_ED_SCHC	DUT supports SCHC	ED	-	FALSE
C_ED_TM_TRI	DUT supports Trigger Join Request command in Test Mode	ED	-	TRUE

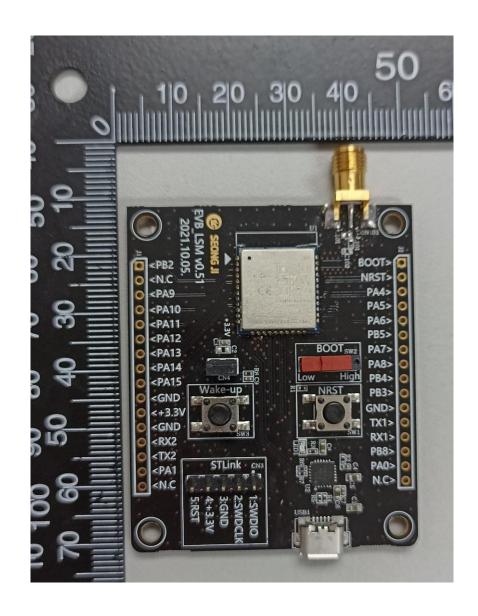
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Appendix C: Photographs

Front view





Rear view

